Quantum Hall conductance of two-terminal graphene devices

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<td><a href="http://hdl.handle.net/1721.1/51027">http://hdl.handle.net/1721.1/51027</a></td>
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Quantum Hall conductance of two-terminal graphene devices

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Measurement and theory of the two-terminal conductance of monolayer and bilayer graphene in the quantum Hall regime are compared. We examine features of conductance as a function of gate voltage that allow monolayer, bilayer, and gapped samples to be distinguished. In particular, we analyze the distortions of quantum Hall plateaus and the conductance peaks and dips at the charge-neutrality point, which can be used to identify the incompressible densities. These results are compared to recent theory and possible origins of the discrepancy are discussed.

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I. INTRODUCTION

Graphene monolayers and bilayers are recently discovered two-dimensional gapless semimetals. The Dirac spectrum of excitations in monolayer graphene gives rise to a number of novel transport properties, including anomalous quantized Hall conductance with plateaus at \( \frac{4}{n+\frac{1}{2}} \) in multiterminal samples. \(^1,^2\) Bilayer graphene has a quadratic, electron-hole-symmetric excitation spectrum, leading to quantized Hall conductance values \( \frac{4n}{e^2} \) in both types of graphene.\(^3,^4\) Both monolayer and bilayer graphene have a zeroth Landau level (LL), located at the charge-neutrality point (CNP), which is eightfold degenerate in bilayers and fourfold degenerate in monolayers. Other Landau levels are all fourfold degenerate in both types of graphene.\(^5-^7\) These unique transport signatures not only reflect this underlying band structure but also serve as an experimental tool for identifying the number of layers and characterizing sample quality.\(^4\)

In recent work on graphene, two-terminal magnetococonductance has emerged as one of the main tools of sample characterization.\(^8-^10\) While a two-terminal measurement is not as straightforward to interpret as the corresponding multiterminal measurement,\(^11\) it is the simplest to perform and may be the only measurement possible, for instance, with very small samples. The presence of nonzero longitudinal conductivity causes quantum Hall (QH) plateaus measured in a two-terminal configuration to not be as well quantized as in multielectrode measurement.\(^4\) As discussed in detail below, plateaus exhibit a characteristic N-shaped distortion arising from the finite longitudinal conductivity that depends on device geometry.

In this paper, we systematically examine two-terminal conductance in the QH regime for monolayer and bilayer graphene for a variety of sample aspect ratios (Table I). We especially focus on the features that can help to distinguish monolayer and bilayer graphene: the conductance extrema in the N-shaped distortions of the quantum Hall plateaus and at the CNP. We find that these features depend on the sample aspect ratio and on the number of graphene layers.

Results are compared to recent theory,\(^12\) in which two-terminal conductance for arbitrary shape is characterized by a single parameter \( \xi \), the effective device aspect ratio (\( \xi = W/L \) for rectangular samples, where \( L \) is the length or distance between contacts and \( W \) is the device width). The N-shaped distortions of the plateaus, arranged symmetrically around the CNP, are consistently observed in the two-terminal conductance measured as a function of carrier density, both in the data presented in this paper and elsewhere.\(^8-^10\) The overall behavior of the conductance is in good qualitative agreement with theoretical results.\(^12\)

In Ref. 12, the positions of conductance extrema on the distorted plateaus were found to align with the incompressible densities, where the centers of quantized plateaus occur in multiterminal devices. In particular, it was predicted that in short samples (\( \xi < 1 \)) the conductance minima are centered around the incompressible densities. On the other hand, for narrow samples (\( \xi > 1 \)) the maxima of the conductance are expected to occur at the incompressible densities. Here we demonstrate that this relation can be used to distinguish monolayer and bilayer graphene devices even when the distortions of the plateaus are strong. We find that the maxima (or the minima) line up with incompressible densities precisely in the way expected for the monolayer and bilayer graphene.

The correlation between the maxima (minima) and incompressible densities is unambiguous; it is supported by all measurements presented in the paper. We analyze data for several rectangular two-terminal samples as well as for one sample with asymmetric contacts, extracting an effective sample aspect ratio via conformal mapping. Best-fit values of

<table>
<thead>
<tr>
<th>Sample</th>
<th>Layers (inferred)</th>
<th>( L/W ) (( \mu m ))</th>
<th>( \xi )</th>
<th>( \xi_{fit} )</th>
</tr>
</thead>
<tbody>
<tr>
<td>A1</td>
<td>Monolayer</td>
<td>(1.3, 1.8)</td>
<td>0.7</td>
<td>1.7</td>
</tr>
<tr>
<td>A2</td>
<td>Monolayer</td>
<td>(0.4, 2.0)</td>
<td>0.2</td>
<td>0.2</td>
</tr>
<tr>
<td>B1</td>
<td>Bilayer</td>
<td>(2.5, 1.0)</td>
<td>2.5</td>
<td>0.8</td>
</tr>
<tr>
<td>B2</td>
<td>Bilayer</td>
<td>(0.3, 1.8)</td>
<td>0.2</td>
<td>0.3</td>
</tr>
<tr>
<td>C</td>
<td>Monolayer</td>
<td>Asymmetric</td>
<td>0.9</td>
<td>0.9</td>
</tr>
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\(^\text{a} \) Effective aspect ratio, see Sec. IV.
A gap in the spectrum of bilayer graphene opens when the aspect ratio \( \xi = L/W \) is \( \approx 2 \) (lower curve) and \( 0.5 \) (upper curve). Finite longitudinal conductivity due to the states in the middle of each Landau level distorts the plateaus into N-shaped structures, which are of opposite sign for \( \xi < 1 \) and \( \xi > 1 \). Local extrema of \( g \) at filling factors \( v = \pm 2, \pm 6, \pm 10, \ldots \) for single layers and at \( v = \pm 4, \pm 8, \pm 12, \ldots \) for bilayers are either all maxima (\( \xi > 1 \)) or all minima (\( \xi < 1 \)).

(a) and (b) For gapless monolayer and bilayer samples, \( g(v=0) \) is a maximum for \( \xi < 1 \) and minimum for \( \xi > 1 \) and (c) for the gapped bilayer \( g \) vanishes at \( v=0 \) for all \( \xi \).

A. Qualitative discussion

Representative theoretical plots of two-terminal conductance for monolayer, bilayer, and gapped bilayer graphene as a function of filling factor, \( v \), are shown in Fig. 1. For both monolayers and bilayers, the absence of an energy gap between the conduction and valence bands gives rise to a zero-energy LL, which can either increase or decrease the two-terminal conductance around the charge-neutrality point, depending on the aspect ratio of the sample. The eightfold degeneracy of the zero-energy LL in bilayer graphene enhances the size of this feature relative to monolayer graphene.

A gap in the spectrum of bilayer graphene opens when the on-site energy in one layer differs from the on-site energy in the other. This may result, for instance, from asymmetric chemical doping or electrostatic gating. The gap splits the zero-energy LL, suppressing conductance at the CNP. The qualitative effect of a gap in the bilayer spectrum can be seen in Fig. 1 by comparing the gapped case [Fig. 1(c)], which always has a zero of conductance at \( v=0 \), to the gapless cases [Figs. 1(a) and 1(b)], which have a nonzero value of conductance at \( v=0 \).

Also illustrated in Fig. 1 is how the aspect ratio of the sample affects the two-terminal conductance near quantum Hall plateaus for all three spectrum types. Finite longitudinal conductivity leads to N-shaped distortions of the plateaus, which are of opposite signs for aspect ratios \( \xi < 1 \) and \( \xi > 1 \). Note, however, that the extrema of conductance—minima for \( \xi < 1 \) and maxima for \( \xi > 1 \)—are aligned with the plateaus centers, which coincide with the incompressible density values (different for monolayers and bilayers). Distorted plateaus thus remain useful for characterizing the number of layers and density.

The back-gate dependence of conductance for the five samples reported are most similar to those in Figs. 1(a) and 1(b), indicating that these samples are single layers and gapless bilayers only (see Table I). We use the model of Ref. 12 to fit the conductance data treating the aspect ratio as a fit parameter. In doing so, our presumption is that the visible dimensions of the sample may not reflect the actual pattern of current flow. Since the conductance problem for a sample of any shape can be reduced to that of an effective rectangle via a conformal mapping, which depends on the sample shape but not on the conductivity tensor, the rectangular geometry is universal for two-terminal conductance. Thus the model of a conducting rectangle with an unspecified aspect ratio is suitable for describing systems in which current pattern is not precisely known.

B. Sample fabrication and measurement

Graphene devices were fabricated by mechanically exfoliating highly oriented pyrolytic graphite onto a \( n^+ \) Si wafer capped with \( \sim 300 \) nm of SiO\(_2\). Potential single and bilayer graphene flakes were identified by optical microscopy. Source and drain contacts, defined by electron-beam lithography, were deposited by thermally evaporating 5/40 nm of Ti/Au. The aspect ratio, \( \xi_r \), of each sample was measured using either optical or scanning electron microscopy after transport measurements were performed.

Devices were measured in a \(^3\)He refrigerator allowing dc transport measurements in a magnetic field \( |B| < 8 \) T perpendicular to the graphene plane. Unless otherwise noted, all measurements were taken at base temperature, \( T = 250 \) mK. Differential conductance \( g = dI/dV \), where \( I \) is the current and \( V \) is the source-drain voltage, was measured using a current bias \( I \) chosen to keep \( eV < k_BT \) and standard lock-in technique at a frequency of 93 Hz. All samples show \( B=0 \) characteristics of high-quality single-layer and bilayer graphene; a CNP positioned at back-gate voltage \( V_{bg} \approx 0 \) V and a change in \( g \) exceeding \( 20e^2/h \) over the \( V_{bg} \) range of \( \pm 40 \) V.

II. MONOLAYER SAMPLES

Figure 2(a) shows the two-terminal conductance \( g(V_{bg}) \) for sample A1 (\( \xi_r = 0.7 \)) at \( B = 8 \) T (trace). Plateaus are seen
FIG. 2. (Color online) (a) Inset: conductance $g$ in the quantum Hall regime as a function of $B$ and $V_{bg}$ at $T=250$ mK for sample A1. Dashed lines correspond to filling factors $\nu=-6,-10,-14,-18$ and align with the local maxima of conductance. Main: horizontal cut of $g$ in the quantum Hall regime as a function of $B$ and $V_{bg}$ at $T=250$ mK for sample A2. Dashed lines correspond to filling factors where quantum Hall states form as well as a sharp peak at the CNP observed for sample A2. The dashed curve was vertically displaced for clarity.

Measured $g(V_{bg})$ [curve in Fig. 2(b)] for sample A2 ($\xi_r=0.2$), made using the same graphene flake as A1, shows distinctive differences from the measured $g(V_{bg})$ of sample A1. In particular, at the CNP ($V_{bg}=-1.5$ V), $g$ exhibits a sharp peak with a maximal value $\sim 8.8e^2/h$. Away from the CNP, the conductance has maxima, which are much stronger than those of sample A1. The inset of Fig. 2(b) shows $g(V_{bg},B)$. For this sample, the dashed lines representing the incompressible filling factors $-6,-10,-14,-18$ now align with the minima in $g$. Here we used $\alpha=6.7 \times 10^{10}$ cm$^{-2}$ V$^{-1}$ (the same as for sample A1) and $V_{offset}=-1.1$ V.

The observed features in $g$ for samples A1 and A2 can be compared to theory$^{13}$ for two-terminal quantum Hall conductance, which uses a model of a conducting rectangle $L \times W$ with a spatially uniform conductivity. The filling factor dependence of the conductivity tensor is obtained using the semiclassical relation for quantum Hall systems, derived in Ref. 21, which is applied independently for each Landau level. Landau-level broadening due to disorder is included in the theory as a Gaussian broadening $e^{-x^2/(2\sigma)}$, where $\nu_c$ is the center of the LL and $\sigma$ is a fitting parameter. The total conductivity tensor is taken to be a sum of the contributions of individual Landau levels. The current-density distribution for a rectangular sample with an arbitrary aspect ratio is found analytically by conformal mapping (see Refs. 16–18). The current density is then integrated numerically along suitably chosen contours to evaluate total current and voltage drop, from which $g=I/V$ is obtained.

Along with the experimental traces, Figs. 2(a) and 2(b) also show the theoretical curves for $\xi_{fit}$ (solid trace) and for $\xi_r$ (dashed trace) ratios. For sample A1, $\xi_{fit}=1.7$ differs considerably from $\xi_r=0.7$. The best fit to the experimental data gives $\lambda=1.2$. This theoretical curve ($\xi_{fit}=1.7$) reproduces the essential features of the data: local maxima align with the filling factors $\pm 2, \pm 6, \pm 10, \ldots$ and $g$ exhibits a dip at the CNP.

The alignment of conductance minima with the integer filling factors where quantum Hall states form as well as a peak at the CNP observed for sample A2 are consistent with theoretical predictions for a short, wide monolayer graphene sample. As illustrated in Fig. 2(b), $\xi_{fit}=0.2$ matches the measured $\xi_r$ for sample A2.

We observe that the size of peaks and dips in Figs. 2(a) and 2(b) increases for higher LL. In contrast, theory$^{12}$ predicts that peaks and dips at $|\nu|>0$ LLs are all roughly the same. This discrepancy may reflect the inapplicability of the two-phase model approach of Ref. 21, which underlies the semiclassical law obtained in this work, to higher LLs. Indeed, because for Dirac particles the spacing between LLs decreases at higher energies as an inverse square root of the level number, one may expect mixing between non-nearest LLs to increase at high energies. Such mixing can lead to the longitudinal conductivity values in excess of those of Ref. 21, which only considers mixing between nearest LLs (see the discussion in Ref. 22).

To take these effects into account, we extend the model of Ref. 12 by assuming that the contribution of the $n$th LL to
the conductivity tensor in monolayer graphene is described by a modified semi-circle (elliptic) law,
\[ \delta_i \sigma_{xx}^2 + A_0^2(\delta_i \sigma_{xy}^0(\delta_i \sigma_{yy}^0 - \sigma_{xy}^0) = 0, \]
where \( \delta_i \sigma_{xx} \) and \( \delta_i \sigma_{xy} \) are the effective longitudinal and Hall conductivities and \( \sigma_{xy}^0 \) and \( \sigma_{yy}^0 \) are the quantized Hall conductivities at the neighboring plateaus. Here \( n \) and \( n' \) are neighboring LL indices, related by \( n' = n + 1 \) (except the doubly degenerate \( \nu = 0 \) LL for the bilayer, in which case \( n = -1 \) and \( n' = 1 \)). The \( A_n \) account for departures from the semi-circle law. We take \( A_n = 1 \) for \( n = 0, \pm 1 \) and \( A_n = 2 \) for other LLs, consistent with previous observations.

### III. BILAYER SAMPLES

The curve in Fig. 3 shows measured \( g(V_{bg}) \) for sample B1 (\( \xi_e = 2.5 \)) at \( B = 8 \) T and \( T = 4 \) K. This sample has two features indicating that it is a bilayer sample: plateaus in conductance appearing near 4, 8, 12, and \( 16e^2/h \), and a conductance maximum at the CNP whose relative size is much larger than those at higher LLs. The conductance values at the plateaus \( \nu = \pm 4 \) here are lower than the expected \( 4e^2/h \) for a bilayer sample, falling to \( 2.7(3.1)e^2/h \) on the electron (hole) side of the CNP. The peak value in conductance at \( \nu = 0 \) (\( V_{bg} = 0.5 \) V) is \( 5e^2/h \). At higher filling factors, the plateaus exhibit two different behaviors, showing a flat plateau at \( \nu = 8 \) and a plateau followed by a dip at \( \nu = 12 \). The small dips align with the filling factors \( \nu = -12, -16, -20 \) for \( 5 < B < 8 \) T (see inset of Fig. 3), using \( \alpha = 7.2 \times 10^{10} \) cm \( ^2 \) V \(^{-1} \) and \( V_{offset} = 0.5 \) V.

Theoretical \( g \) curves for aspect ratios \( \xi_e = 2.5 \) (dashed curve) and \( \xi_f = 0.8 \) (solid curve), obtained using the semi-circle relation, are shown in Fig. 3. Theoretical \( g(V_{bg}) \) curves for these two aspect ratios are similar at high density but differ for \( \nu = 0 \): the curve for \( \xi_e = 2.5 \) has a dip in conductance at the CNP while \( \xi_f = 0.8 \) has a peak, similar to the experimental curve. The curve for \( \xi_f = 0.8 \) also agrees better with experiment at higher densities.

### IV. NONRECTANGULAR SAMPLES

In this section we extend the comparison of theory and experiment to a nonrectangular device, sample C, shown schematically in the inset of Fig. 5. The measured two-terminal conductance of sample C (curve in Fig. 5) has properties very similar to those expected for a square monolayer sample: around the CNP the conductance is nearly flat with value \( \sim 2e^2/h \), monotonically increasing on the electron and hole sides at filling factors \( |\nu| > 2 \).

The theoretical curve shown in Fig. 5 is obtained from the conducting rectangle model and the semi-circle relation, for \( \xi_f = 0.9 \) and \( \lambda = 0.7 \). This choice of parameters yields particu-
larly good agreement for $|v| \leq 6$. At higher fillings, the plateaus are washed out, suggesting that the LL broadening is stronger for LLs $|v| \geq 2$. It is interesting to compare $\xi_{\text{fit}}$ to an effective aspect ratio obtained from conformal mapping of sample C to a rectangle. As discussed below, this conformal mapping can be constructed directly, owing to the relatively simple geometry of sample C. The effective aspect ratio obtained in this way is $\xi_e = 0.9$, consistent with $\xi_{\text{fit}}$.

Before we proceed to construct the conformal mapping we note that the geometry of sample C, pictured in Fig. 6, is that of a polygon. In principle, any polygon can be mapped onto the upper half plane by inverting a Schwarz-Christoffel mapping. However, since this mapping is defined by a contour integral, the inverse mapping can only be found numerically. In order to circumvent this difficulty, two approximations are employed below, allowing the desired mapping to be constructed as a composition of a few simple mappings.

The steps involved in this construction are illustrated in Fig. 7. First, the rectangular shape in Fig. 6 is replaced with a semi-infinite strip shown in Fig. 7(a). This approximation should not significantly affect the conductance, as the current flows mostly in the region between contacts 1-2 and 3-4.

Without loss of generality we set the length scale $\xi = a = 1$.

The next step is to straighten out the contact 3-5-6-4. For that, let us consider an auxiliary mapping that maps the upper $\tilde{w}$ plane onto the upper $\tilde{z}$ plane with a removed rectangle.24

$$\tilde{z} = iA = \int_{0}^{\tilde{a}} \left( \frac{\xi^2 - 1}{\xi^2 - 2} \right)^{1/2} d\xi. \quad (2)$$

We choose the parameter $A$ to be equal to

$$A = \int_{0}^{1} \left( \frac{\xi^2 - 1}{\xi^2 - 2} \right)^{1/2} d\xi \approx 0.60, \quad (3)$$

so that the removed rectangle has vertices

$$\tilde{z}_{3,4} = \pm A, \quad \tilde{z}_{5,6} = \pm A + iA. \quad (4)$$

These points correspond to the points $\tilde{w}_{3,4} = \pm \sqrt{2}$, $\tilde{w}_{5,6} = \pm 1$ in the $\tilde{w}$ plane. The value of $A$ ensures that the edge of the sample on the $x$ axis remains on the $x$ axis under the mapping [Eq. (2)]. The distance between points $\tilde{z}_3$ and $\tilde{z}_5$ plane equals $A$, as follows from Eq. (2) and the identity

$$\int_{1}^{\tilde{a}} \left[ \frac{\xi^2 - 1}{\xi^2 - 2} \right]^{1/2} d\xi = \int_{0}^{1} \left( \frac{\xi^2 - 1}{\xi^2 - 2} \right)^{1/2} d\xi, \quad (5)$$

which can be proved by making the change in variables, $\xi = \sqrt{2} - x$ in the integral in the left-hand side of Eq. (5) and $\xi = \sqrt{x}$ in the integral in the right-hand side of Eq. (5).

The removed rectangle has an aspect ratio equal to 2, the same as that for the contact 3-5-6-4; however, their dimensions differ by a factor of $A$. Scaling and shifting both $\tilde{z}$ in $\tilde{w}$,

$$\tilde{z} = A(z - 5), \quad \tilde{w} = A(w - 5), \quad (6)$$

FIG. 5. (Color online) Measured $g(V_{bg})$ for sample C and calculated conductance (solid curve) for $\xi_{\text{fit}} = 0.9 \ (\lambda = 0.7)$. The asymmetric contacts of this sample can be conformally mapped onto a rectangle, producing a device aspect ratio of $\xi_e = 0.9$ (dashed curve). The dashed curve was vertically displaced for clarity.

FIG. 6. A polygon representing sample C (see Fig. 5). Black regions correspond to contacts (length scale $a = 200 \ \text{nm}$).

FIG. 7. (Color online) Three steps used to map the polygon in Fig. 6 (sample C) onto the upper half plane (schematic). (a) First, the rectangle in Fig. 6 is replaced by a half-infinite strip, extending indefinitely to the right. (b) Next, we map the domain shown in (a) onto a rectangle with contact 3-5-6-4 straightened out. Under this mapping, the sample is slightly distorted, as indicated by the gray polygon in (b). (c) Because the deviation of the gray polygon boundary from the original sample boundary [serrated rectangle in (b), red online] is fairly small, it can be neglected, giving a half-infinite strip. (d) Finally, the domain (c) is mapped onto the upper half plane, which allows to find the cross ratio $\Delta_{1234}$, Eq. (9), and evaluate the effective aspect ratio, Eq. (10).
we obtain the required mapping, which straightens out the contact 3-5-6-4.

The second approximation is necessary because the mapping Eqs. (2) and (6), while straightening the segments 3-5-6-4, distorts the rest of the boundary. We notice, however, that sufficiently far from the contact 3-5-6-4 the mapping Eq. (2) is close to the identity,

\[ \zeta(w \gg 1) = w + O(1/w), \quad |z-s| \gg 1. \]  

(7)

This property and the relatively small size of the segments 3-5-6-4 compared to the strip width guarantees that the distortion is small. This is shown schematically in Fig. 7(b), where the curved gray polygon represents the actual image of the sample, with the deviation of its boundary from the strip of the same asymptotic width (solid line). The deviation is indeed small; by investigating the mapping Eqs. (2) and (6) numerically we found that the boundary is displaced the most at point 2, which is shifted by approximately 0.3 away from its original position 2’ along the real axis. This is small compared to the sample width, equal to 6, which allows us to neglect the displacement of the boundary. Thus we assume that the mapping Eqs. (2) and (6) transforms sample C into the semi-infinite strip shown in Fig. 7(c).

After this approximation is made, it is straightforward to transform the semi-infinite strip in Fig. 7(c) into the upper half plane, which can be done by the mapping

\[ \zeta = \cosh \frac{\pi w}{6}. \]  

(8)

In the \( \zeta \) plane, the contacts are mapped on the real axis with the end points 1, 2, 3, and 4 mapped to \( \zeta_1 = -1 \), \( \zeta_2 = 1 \), \( \zeta_3 = 2.11 \), and \( \zeta_4 = 23.57 \). From these values, following the procedure described in Ref. 12 (Appendix), we compute the cross ratio

\[ \Delta_{1234} = \frac{(\zeta_1 - \zeta_4)(\zeta_3 - \zeta_2)}{(\zeta_1 - \zeta_2)(\zeta_3 - \zeta_4)} \approx -0.64, \]  

(9)

and then obtain the aspect ratio from the relations

\[ \xi_s = \frac{L}{W} = \frac{K(k')}{2K(k)}, \quad \Delta_{1234} = (1-k^2)/2k, \]  

(10)

where \( K(k) \) is the complete elliptic integral of the first kind and \( k' = (1-k^2)^{1/2} \). This procedure yields the value \( \xi_s = 0.9 \), identical to that found from the best fit to a conducting rectangle model (see Fig. 5).

V. SUMMARY AND DISCUSSION

In summary, we have studied the effect of geometry on the conductance of two-terminal graphene devices in the QH regime, comparing experiment and theory. The QH plateaus typically exhibit conductance extrema that are stronger for wide and short samples. For wide samples \( (\xi_{\text{fit}} < 1) \), minima of the two-terminal conductance are expected at filling factors where plateaus would be found in multiterminal devices. On the other hand, for narrow samples \( (\xi_{\text{fit}} > 1) \), conductance maxima appear at those filling-factor values. Having in hand a value for the aspect ratio of the sample, one can then use the alignment of either the minima (for \( \xi_{\text{fit}} < 1 \)) or the maxima (for \( \xi_{\text{fit}} > 1 \)) with particular filling factors to infer the number of layers. For instance, alignment of the appropriate extrema with filling factors 2, 6, 10, etc. implies that the sample is a single layer, whereas alignment with filling factors 4, 8, 12, etc. implies that the sample is a bilayer. This type of analysis can be extended to nonrectangular samples; the equivalent rectangle approach appears to work well.

We find for the five samples measured that conductance as a function of gate voltage shows relatively good agreement with theory for short samples \( (L \leq 1 \mu \text{m}) \); in longer samples the best-fit aspect ratio differs considerably from the measured sample aspect ratio. We note that using the fit value \( \xi_{\text{fit}} \) for the effective aspect ratio can be more reliable than using the value \( \xi_s \) measured from the micrograph because invisible partial contact can alter the effective aspect ratio.

What could be the physical mechanism of such partial contact? One effect to consider is contact resistance, which would lead to an overall reduction in the experimentally observed values of conductance. In devices fabricated using similar methods to the two-terminal devices in this experiment but with four or more terminals, it is found that contact resistance in the quantum Hall regime at the charge-neutrality point is on the order of 500 \( \Omega \), dropping to \( \sim 100 \Omega \) away from charge neutrality for contacts with similar contact area as the ones used in this experiment. This contact resistance is a small fraction of the resistances measured in the graphene sheet in the quantum Hall regime; hence, we rule out the possibility of contact resistance being a main source of discrepancy with theory.

There are scenarios, however, in which contact effects can play a role in altering the aspect ratio. One is that only part of the contact actually injects current, reducing the effective width and causing \( \xi_{\text{fit}} \) to be greater than \( \xi_s \), as observed in sample A1. Another possibility is that the contacts locally dope the graphene, causing the actual aspect ratio to be smaller. However, for doping to make \( \xi_{\text{fit}} < \xi_s \) in sample B1, it would have to penetrate \( \approx 500 \text{nm} \) into the graphene, at least two orders of magnitude more than expected. 25

Another more interesting possibility could be that the picture of an effective medium characterized by local conduction, on which the argument leading up to the semicircle relation 21 is based, may not hold. This might arise, for instance, from large density fluctuations, giving rise to electron and hole puddles 26 forming a network of \( p-n \) interfaces along which conduction occurs. In this case, the effect of the back gate is to alter the percolation properties of this \( p-n \) network. Magnetotransport across multiple \( p-n \) interfaces cannot be accurately described in terms of a local conductivity model. This situation arises when the distance between contacts is much greater than the scale of disorder, which we take to be \( \approx 500 \text{nm} \) following Ref. 20. This suggests that samples A1 and B1 should show greater deviation from the present theory than samples A2 and B2, which is indeed the case experimentally. Transport mediated by such states would almost certainly change the conventional picture of local conduction. Further studies are required to clarify the physical mechanism responsible for the observed behavior.
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24 Online conformal mapping dictionary, example 51, http://math.fullerton.edu/mathews/c2003/ConformalMapDictionary.5.html